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## Supplementary Materials for

## **Peroptronic Devices: Perovskite Based Light-Emitting Solar Cells**

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This PDF includes:

Figures S1-S4

Table S1-S2



**Figure S1.** Characteristics of two-step, solution-processed MAPbBr<sub>3</sub> films. (a) SEM image. (b) X-ray diffractogram. (c) Absorption and photoluminescence spectra.



**Figure S2.** Optical properties. (a) Absorption and PL of ZnO ETL. (b) Absorption and PL of ZnO ETL. (c) Tauc plots of ZnO and TPBI ETLs. (d) Tauc plots of MAPbBr<sub>3</sub> films prepared by one step and two step methods.



**Figure S3.** UPS spectra. (a) Close-up of Fermi edge region of different films. (b) Close-up of secondary edge region of different films. For these measurements, thin ETL layers were deposited onto one-step MAPbBr<sub>3</sub> layers.

Structure	<i>WF</i> (eV)	Е <sub>VB</sub> (eV)	Е <sub>св</sub> (eV)	E <sub>g</sub> (eV)
MAPbBr₃	5.31	5.74	3.46	2.28
ZnO	4.88	7.53	4.18	3.35
PEI	4.86	7.17	1.13	6.04
PEIBIm <sub>4</sub>	n <sub>4</sub> 4.64		2.14	5.17
TPBI	4.66	6.53	3.08	3.45

**Table S1.** Energy levels of different films deposited on MAPbBr<sub>3</sub> derived from UPS and UV-vis data.



**Figure S4.** Solar cell and LED characteristics of MAPbBr<sub>3</sub> devices prepared using the 2-step method. (a) J-V characteristics under 100 mW/cm-2 simulated solar irradiation. (b) J-V characteristics under forward bias. (c) Luminance vs applied bias. (d) Luminous efficiency vs applied bias.

Structure	J <sub>sc</sub> (mA/cm²)	V <sub>oc</sub> (V)	FF	PCE (%)	L <sub>max</sub> * [cd m <sup>-2</sup> ]	L <sub>max</sub> * [cd A⁻]	L <sub>max</sub> * [Im W <sup>-</sup> ]	EQE* [%]
ZnO	3.93	1.39	0.72	3.92	0.039 @ 3.8	0.00002 @ 3.8	0.000016 @ 3.8	0
PEI	0.18	0.85	0.17	0.025	91.55 @ 3.8	0.071 @ 2.8	0.08 @ 2.8	0.016 @ 2.8
PEIBIm <sub>4</sub>	1.29	1.04	0.52	0.70	1685.30 @ 3.8	0.25 @ 3.8	0.21 @ 3.6	0.056 @ 3.8
ТРВІ	0.56	0.59	0.29	0.096	525.65 @ 4.6	0.077 @ 4.6	0.052 @ 4.6	0.017 @ 4.6

**Table S2.** Optoelectronic characteristics of LESC devices with MAPbBr<sub>3</sub> prepared by the twostep method.

\*The potential (in V) at which each parameter was measured is denoted after the symbol @.